

<b>Notice of References Cited</b>		Application/Control No. 10/549,304	Applicant(s)/Patent Under Reexamination TOYAMA ET AL.	
		Examiner STAMFORD HWANG	Art Unit 2617	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,491,507	02-1996	Umezawa et al.	348/14.02
*	B	US-2003/0181226 A1	09-2003	Kawata et al.	455/572
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2002271860 A	09-2002	Japan	ANDO et al.	
	O	JP 2002101059 A	04-2002	Japan	SUZUKI et al.	
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.